

Notice of References Cited	Application/Control No. 10/615,600	Applicant(s)/Patent Under Reexamination ONOE ET AL.	
	Examiner Joseph Haley	Art Unit 2653	Page 1 of 1

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*	A	US-2004/0047245	03-2004	Onoe et al.	369/013.01
*	B	US-5,953,306	09-1999	Yi, You-Wen	369/126
*	C	US-6,665,239	12-2003	Takahashi et al.	369/44.23
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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